

Notice of References Cited	Application/Control No. 10/579,312		Applicant(s)/Patent Under Reexamination LIFKA ET AL.	
	Examiner JOSE M. DIAZ		Art Unit 2879	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,226,171 B1	05-2001	Beilin et al.	361/306.3
*	B	US-2004/0223886 A1	11-2004	Liu et al.	422/100
*	C	US-6,873,091 B2	03-2005	Bechtel et al.	313/112
*	D	US-2005/0057151 A1	03-2005	Kuwabara, Hideaki	313/506
*	E	US-2005/0127376 A1	06-2005	Young et al.	257/080
*	F	US-2005/0146279 A1	07-2005	Hector et al.	315/169.3
*	G	US-6,952,490 B2	10-2005	Lee, Ju Hyun	382/124
*	H	US-2005/0255616 A1	11-2005	Childs et al.	438/022
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 03079449 A 1	09-2003	International	CHILDS M J et al.	H01L 27/15
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.